

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under Reexam

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Examiner

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2612

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**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	5,161,026	11/1992	Mabuchi et al.	348	335
B					
C					
D					
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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